

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/759,207	CHAN ET AL.	
Examiner	Art Unit	
Christy L. Novacek	2822	

SEARCHED					
Class	Subclass	Date	Examiner		
438	424	8/4/2005	CN		
438	425	8/4/2005	CN		
438	435	8/4/2005	CN		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
-	DATE	EXMR	
EAST Search USPGPUB USPAT EPO JPO	8/4/2005	CN	